## Application/Control No. Applicant(s)/Patent Under Reexamination 10/748,851 BANINE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2851 D. Rutledge **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2005/0230645 10-2005 Melnychuk et al. 250/504.00R Α US-В US-С US-D Ε US-US-F US-G US-Н US-1 US-US-K US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х